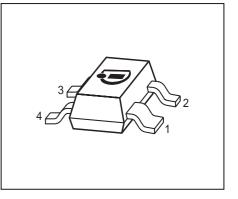


BFP183

NPN Silicon RF Transistor*

- For low noise, high-gain broadband amplifiers at collector currents from 2 mA to 30 mA
- $f_{\rm T} = 8 \text{ GHz}, F = 0.9 \text{ dB} \text{ at } 900 \text{ MHz}$
- Pb-free (RoHS compliant) package¹⁾
- Qualified according AEC Q101
- * Short term description





ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration				Package		
BFP183	RHs	1=C	2=E	3=B	4=E	-	-	SOT143

Maximum Ratings				
Parameter	Symbol	Value	Unit	
Collector-emitter voltage	V _{CEO}	12	V	
Collector-emitter voltage	V _{CES}	20		
Collector-base voltage	V _{CBO}	20		
Emitter-base voltage	V _{EBO}	2		
Collector current	I _C	65	mA	
Base current	I _B	5		
Total power dissipation ²⁾	P _{tot}	250	mW	
<i>T</i> _S ≤ 76 °C				
Junction temperature	T _i	150	°C	
Ambient temperature	T _A	-65 150		
Storage temperature	T _{stg}	-65 150		
Thermal Resistance				

Parameter	Symbol	Value	Unit
Junction - soldering point ³⁾	R _{thJS}	≤ 295	K/W

¹Pb-containing package may be available upon special request

 $^{2}T_{S}$ is measured on the collector lead at the soldering point to the pcb

³For calculation of R_{thJA} please refer to Application Note Thermal Resistance



Parameter	Symbol	Values			Unit
		min.	typ.	max.]
DC Characteristics	• • •				•
Collector-emitter breakdown voltage	V _{(BR)CEO}	12	-	-	V
$I_{\rm C} = 1 {\rm mA}, I_{\rm B} = 0$					
Collector-emitter cutoff current	I _{CES}	-	-	100	μA
$V_{\rm CE} = 20 \text{ V}, \ V_{\rm BE} = 0$					
Collector-base cutoff current	I _{CBO}	-	-	100	nA
$V_{\rm CB} = 10 \text{ V}, I_{\rm E} = 0$					
Emitter-base cutoff current	I _{EBO}	-	-	1	μA
$V_{\rm EB} = 1 \text{V}, I_{\rm C} = 0$					
DC current gain-	h _{FE}	70	100	140	-
$I_{\rm C}$ = 15 mA, $V_{\rm CE}$ = 8 V, pulse measured					

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified



Parameter	Symbol		Unit			
		min.	typ.	max.		
AC Characteristics (verified by random samplin	g)					
Transition frequency	f _T	6	8	-	GHz	
$I_{\rm C} = 25 \text{ mA}, V_{\rm CE} = 8 \text{ V}, f = 500 \text{ MHz}$						
Collector-base capacitance	C _{cb}	-	0.3	0.5	pF	
$V_{\rm CB} = 10 \text{ V}, \ f = 1 \text{ MHz}, \ V_{\rm BE} = 0 ,$						
emitter grounded						
Collector emitter capacitance	C _{ce}	-	0.27	-		
$V_{CE} = 10 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$,						
base grounded						
Emitter-base capacitance	C _{eb}	-	1.1	-		
$V_{\text{EB}} = 0.5 \text{ V}, \ f = 1 \text{ MHz}, \ V_{\text{CB}} = 0 $						
collector grounded						
Noise figure	F				dB	
$I_{\rm C} = 5 \text{ mA}, V_{\rm CE} = 8 \text{ V}, Z_{\rm S} = Z_{\rm Sopt},$						
<i>f</i> = 900 MHz		-	0.9	-		
<i>f</i> = 1.8 GHz		-	1.4	-		
Power gain, maximum stable ¹⁾	G _{ms}	-	22	-	dB	
$I_{\rm C}$ = 15 mA, $V_{\rm CE}$ = 8 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, $Z_{\rm L}$ = $Z_{\rm Lopt}$,						
<i>f</i> = 900 MHz						
Power gain, maximum available ¹⁾	G _{ma}	-	15.5	-	dB	
$I_{\rm C}$ = 15 mA, $V_{\rm CE}$ = 8 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$, $Z_{\rm L}$ = $Z_{\rm Lopt}$,						
<i>f</i> = 1.8 GHz						
Transducer gain	S _{21e} ²				dB	
$I_{\rm C}$ = 15 mA, $V_{\rm CE}$ = 8 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 Ω ,	_					
<i>f</i> = 900 MHz		-	17.5	-		
<i>f</i> = 1.8 GHz		-	11.5	-		

Electrical Characteristics at $T_A = 25^{\circ}C$, unless otherwise specified

 ${}^{1}G_{\mathsf{ma}} = |S_{21e} / S_{12e}| \; (\mathsf{k}\text{-}(\mathsf{k}^{2}\text{-}1)^{1/2}), \; G_{\mathsf{ms}} = |S_{21} / S_{12}|$



nH

nH

nH

nH

nH

nH

fF

fF

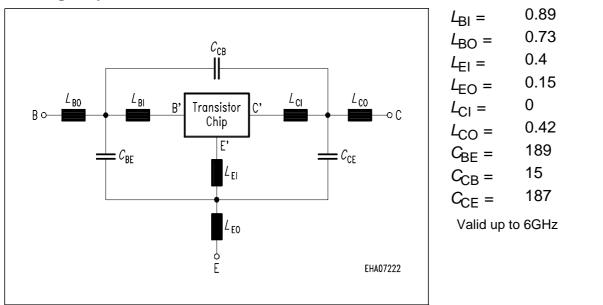
fF

SPICE Parameter (Gummel-Poon Model, Berkley-SPICE 2G.6 Syntax):

Transistor Chip Data:										
IS =	1.0345	fA	BF =	115.98	-	NF =	0.80799	-		
VAF =	14.772	V	IKF =	0.14562	А	ISE =	16.818	fA		
NE =	1.2149	-	BR =	10.016	-	NR =	0.99543	-		
VAR =	3.4276	V	IKR =	0.013483	А	ISC =	1.3559	fA		
NC =	0.85331	-	RB =	2.5426	Ω	IRB =	0.43801	mΑ		
RBM =	1.0112	Ω	RE =	1.3435	-	RC =	0.20486	Ω		
CJE =	23.077	fF	VJE =	1.0792	V	MJE =	0.45354	-		
TF =	22.746	ps	XTF =	0.36823	-	VTF =	0.50905	V		
ITF =	1.8773	mA	PTF =	0	deg	CJC =	460.11	fF		
VJC =	1.1967	V	MJC =	0.3	-	XCJC =	0.053823	-		
TR =	1.0553	ns	CJS =	0	fF	VJS =	0.75	V		
MJS =	0	-	XTB =	0	-	EG =	1.11	eV		
XTI =	3	-	FC =	0.54852		TNOM	300	K		

All parameters are ready to use, no scalling is necessary. Extracted on behalf of Infineon Technologies AG by: Institut für Mobil- und Satellitentechnik (IMST)

Package Equivalent Circuit:



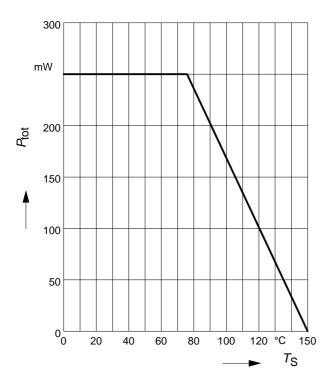
For examples and ready to use parameters please contact your local Infineon Technologies distributor or sales office to obtain a Infineon Technologies CD-ROM or see Internet: http://www.infineon.com



BFP183

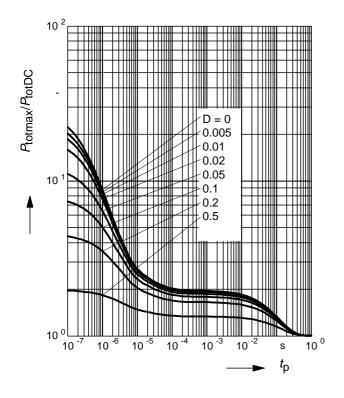
Total power dissipation $P_{tot} = f(T_S)$

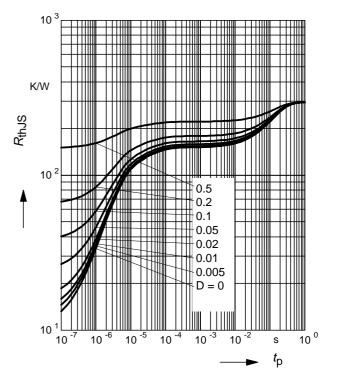
Permissible Pulse Load $R_{\text{thJS}} = f(t_{\text{p}})$



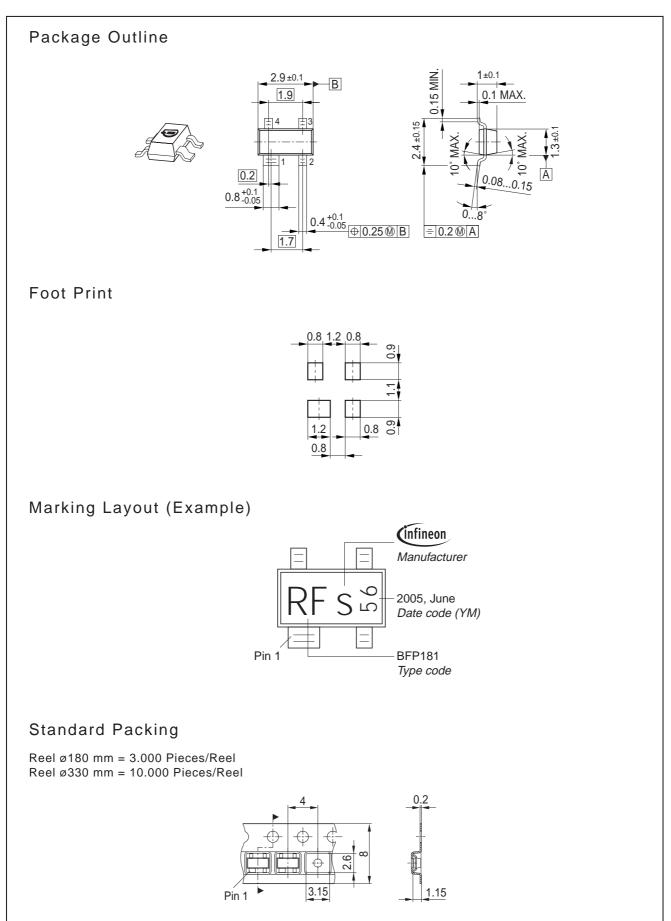
Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{p})$











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